

Notice of References Cited

Application/Control No.

10/615,088

Applicant(s)/Patent Under
Reexamination
YEOH ET AL.

Examiner

DAVID P. RASHID

Art Unit

2624

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,356,672	03-2002	Feng et al.	382/312
	B	US-			
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	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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